

Notice of References Cited	Application/Control No. 10/569,516	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner RAYMOND S. DEAN	Art Unit 2618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0203747	10-2003	Nagamine, Yasuo	455/575.3
*	B	US-6,822,871	11-2004	Lee et al.	361/727
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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